

engineering data service

6788

MECHANICAL DATA

Bulb .																				T-3	
Base .																					
Outline												٠				(See	Dr	av	ving)	
Basing																				8DL	
Cathod	е.													(Coa	ted	l Uı	nipo	ote	ential	
Mounti	ng	Pos	iti	on																Any	
RATING	GS¹	(A	bs	olu	te	Ma	xim	um)												
Im	bac'	t A	cce	ler	atio	on														100	G
Un	ifor	m A	Acc	ele	rat	ioi	n.													1000	G
Fat	igu	e (1	Vib	rat	ior	nal	Acc	cele	ra	tioi	ı fo	r E	xte	nde	ed I	er:	iod	s)		10	G
Bul	lb T	em.	per	ati	ure															250°	C
																			8	30000	Ft.

ELECTRICAL DATA

ELECTR	ICAL I	DATA	
HEATER CHARACTERISTICS			
		Min.	Bogey Max.
Heater Voltage ³		5.7	6.3 6.9 V
Heater Current	•		175 mA
DIRECT INTERELECTRODE CAPACIT.	ANCES	(Shielded)	4
Grid No. 1 to Plate			. 0.032 μμf Max.
Input			2.5 μμf
Oûtput			. 3.2 μμf
RATINGS1 & 5 (Absolute Maximum)			
Plate Voltage			. 250 Vdc
Peak Plate Forward Voltage6			. 500 v
Grid No. 2 Voltage			. 150 Vdc
Plate Dissipation			. 0.5 W
Grid No. 2 Dissipation			. 0.15 W
Grid No. 1 Voltage			
Positive Value			. 0 Vdc
Negative Value			. 55 Vdc
Grid No. 1 Circuit Resistance			. 4.0 Meg
CHARACTERISTICS			
Plate Voltage			. 100 Vdc
Grid No. 2 Voltage			. 100 Vdc
Cathode Resistor			. 1500 Ohms
Plate Current			
Grid No. 2 Current			
Transconductance			
Plate Resistance			. 1.2 Meg
Grid No. 1 Voltage for Ib = 10μ M	Adc .		. —2.8 Vdc
White Noise Vibration Output Vo			70 35
Peak to Peak			
RMS			. 5 mVac Max.

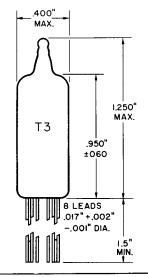
NOTES:

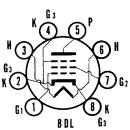
- 1. Limitations beyond which normal tube performance and tube life may be impaired.
- 2. If altitude rating is exceeded, reduction of instantaneous voltages (Ef excluded) may be required.
- 3. Tube life and reliability of performance are directly related to the degree of regulation of the heater voltage to its center rated value of 6.3 volts.
- 4. External shield of 0.405 inch diameter connected to cathode.
- 5. Values shown are as registered with RETMA.
- 6. Per MIL-E-1C, Par. 6.5 and General Section of this Sylvania Subminiature Tube Manual titled Specifications and Ratings.
- 7. White Noise Output Voltage is measured across a plate resistor of 10,000 ohms, with applied vibrational force such that the instantaneous values of acceleration form a "White Noise" spectrum from 100 cps to 5000 cps. Energy within the spectrum is so distributed that in each octave of bandwidth the tube experiences 2.3 G's rms acceleration, and the degree of clipping is such that the peak value of acceleration is 15 G's maximum.

QUICK REFERENCE DATA

The Premium Subminiature Type 6788 is a sharp cutoff pentode designed primarily for use as a high gain audio amplifier or regulator amplifier where high plate loads are desired at low plate currents. The 6788 is characterized by extra-ordinary freedom from interelement shorts of short duration, by high resistance to interelement leakage.

The 6788 is designed to provide dependable service under conditions of severe mechanical shock, vibration, high temperature and high altitude, and is manufactured and inspected to meet the applicable specification for reliable operation.





SYLVANIA ELECTRIC PRODUCTS INC.

RADIO TUBE DIVISION EMPORIUM, PA.

Prepared and Released By The
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ACCEPTANCE CRITERIA

Test Conditions

Heater Voltage	6.3 V	Grid No. 2 Voltage	100 Vdc
Plate Voltage	100 Vdc	Heater-Cathode Voltage	o V
Grid No. 1 Voltage	0 V	Cathode Resistor MIL-E-1 Par. 3.2.2.1	1500 Ohms

For the purposes of inspection, use applicable reliable paragraphs of MIL-E-1 and Inspection Instructions for Electron Tubes.

14U F 1								
MIL-E-I Ref.	Test	(%)	Min.	LAL	Bogey	UAL	Max.	Units
Measurem	ents Acceptance Tests, Part I, Note I							
1.10.8	Heater Current:	0.65	161	_	_	_	189	-mA
4.10.15	Heater-Cathode Leakage: Ehk = +100 Vdc. Ehk = -100 Vdc.	0.65 — —		_ 	_ 	 	5.0 5.0	μAdc μAdc
\$.10.6.1	Grid Current: Ic1 Rg1 = 1.0 Meg	0.65	0	_			-0.1	μAdc
4.1.1.7 4.10.4.1	(Method A) Plate Current (1): ALD = 0.20 Ib	_		0.73	0.8	0.87	_	mAdc
4.10.4.1	Plate Current (1): Ib	0.65	0.6		_		1.0	mAdc
4.10.4.1	Plate Current (2): Ib $Ec1 = -4.0 \text{ Vdc}; Rk = 0 \text{ Ohms}.$	0.65	_				10	μAdc
4.10.4.3	Screen Grid Current: Ic2	0.65	_	_	_ '	_	0.20	mAdc
4.1.1.7 4.10.9	(Method A) Transconductance (1): ALD = 190 Sm.	_	_	1085	1150	1215	_	μmhos
1.10.9	Transconductance (1): Sm	0.65	950		-		1350	μmhos
	Continuity and Shorts (Inoperatives): Note 2	1.0	_			-	_	
4.9.1	Mechanical: Envelope (As Per Outline)	_	_	_	_			
Measurem	ents Acceptance Tests, Part 2							
4.8.2	Insulation of Electrodes:	2.5 — — —	250 250 250	_ _ _		_ _ _ _		Meg Meg Meg
4.10.4.1	Plate Current (3):	2.5		_	_	_	15	%
4.10.6.2	Grid Emission: Note 7 Ic1 Ef = 7.5 V; Rg1 = 4.0 Meg; Rk = 0 Ohms; Ec1 = -4.0 Vdc	2.5	0				-0.5	μAdc
1.10.3.2	AF Noise: Esig = 70 mVac; Ec2 = 19 Vdc; Rg1 = 0.1 Meg; Rg2 = 1000 Ohms; Rp = 0.2 Meg; Ck = 1000 μf	2.5		_	_		17	VU
	Hum: Note 8 Ef = 6.3 at 400 cps; Rg1 = 0 Ohms; Rg2 = 0.03 Meg; RL = 0.01 Meg	2.5			_	_	10	mv pk-pl
	Operation Time: Note 9.	6.5					20	secs
.10.10	Plate Resistance:	6.5	1.0	_	_			Meg
1.10.14	Capacitance: 0.405 In. Dia. Shield Cg1p. 0.405 In. Dia. Shield Cin. 0.405 In. Dia. Shield Cout.	6.5 — —	 1.9 2.4		_ _ _		0.032 3.1 4.0	μμf μμf μμf

ACCEPTANCE CRITERIA (Continued)

.40.51					Limits			
MIL-E-I Test	Test	AQL (%)	Min.	LAL	Bogey	UAL	Max.	Units
Measureme	ents Acceptance Tests, Part 2 (Continued)							
4.9.12.1	Low Pressure Voltage Breakdown: Pressure = 20 ±5 mm Hg.; Voltage = 300 Vac	6.5	_		_	_	_	
4.9.19.1	White Noise: Note 3 $Rp = 10,000 \text{ Ohms}; Ck = 1000 \mu f;$ Peak Acceleration = 15 G	2.5 2.5	Ξ	<u>-</u>	<u>-</u>	<u> </u>	50 5	mv pk-pk mVac
Degradatio	on Rate Acceptance Tests, Note 4							
4.9.5.3	Subminiature Lead Fatigue:	2.5	2	_	_	_		arcs
4.9.20.5	Shock: Hammer Angle == 10.5°	20	_	_	_	_	-	
4.9.20.6	Fatigue: Note 6 G = 10; Variable Frequency	6.5	_	_	_	_		
	Post Shock and Fatigue Test End Points: White Noise	_	=	_ _	<u>-</u>	- 1	50.0 5.0	mv pk-pk mVac
	Heater-Cathode Leakage Ehk = +100 Vdc. Ehk = -100 Vdc.	_	_ _	_ _	_	_	5.0 5.0	μAdc μAdc
	Change in Plate Current (1) of Individual Tubes △ Ib		_	_			20	%
4.9.6.3	Glass Strain:	6.5	_		_	_		

			Allowable per Char	Lin			
MIL-E-I Ref.	Test	AQL (%)	lst Sample			Max.	Units
Acceptanc	e Life Tests, Note 4						
4.11.3.1	Stability Life Test: (1 Hour) Eb = 250 Vdc; Ec2 = 150 Vdc; Rk = 680 Ohms; Ehk = +200 Vdc; Rg1 = 4.0 Meg; TA = Room	1.0	_		_	_	
4.11.4	Stability Life Test End Points: Change in Plate Current (1) of Individual Tubes △ Ib			_	SE-Service	15	%
1.11.3.1 1.11.3.1.1	Survival Rate Life Test: (100 Hours) Stability Life Test Conditions or Equivalent; TA = Room	_	_	_	_	_	
.11.4	Survival Rate Life Test End Points: Continuity and Sorts (Inoperatives)	1.5			_	_	
	Change in Plate Current (1) of Individual Tubes △ Ib	1.0	_	-	_	15	%
1.11.7	Heater Cycling Life Test: Ef = 7.0 V; 1 min. on, 4 min. off; Ehk = 140 Vac; Ec1 = Ec2 = Eb = O V	2.5			_		
.11.5 .11.3.1	Intermittent Life Test: Note 5 Stability Life Test Conditions; T Envelope = +250°C min.; 1000 Hour Requirements Do Not Apply		_		_		

ACCEPTANCE CRITERIA (Continued)

		AQL (%)	Allowable per Chai	Lin	nits		
MIL-E-I Ref.	Test		lst Sample	Combined Samples	Min.	Max.	Units
Acceptanc	 re Life Tests, Note 4 (Continued)						
4.11.3.1 4.11.4	Intermittent Life Test End Points: (500 Hours) Inoperatives Grid Current Ic1 Heater Current Change in Plate Current (1) of Individual Tubes △ Ib Plate Current (3) △ Ib Heater-Cathode Leakage Ehk = +100 Vdc Ehk = -100 Vdc. Insulation of Electrodes g1-all p-all g2-all Total Defectives		1 1 2 1 2 2 2 2 4	3 3 5 3 5 5 			μAdc mA % % μAdc μAdc μAdc μAdc

ACCEPTANCE CRITERIA NOTES:

- 1: The AQL for the combined defectives for attributes in Measurements Acceptance Tests, Part 1, excluding inoperatives and mechanical shall be one (1) percent. A tube having one (1) or more defects shall be counted as one (1) defective.
- 2: All tubes shall be tested for continuity of all circuits, including duplicate pin connections to the same electrode; for shorts between any of the tube elements or between the elements and the no-connection base pins; and for air leaks.

Testing for shorts shall be performed using the Sylvania Automatic Tapper, B5-1379-A6. Each tube shall be tapped a total of six taps, three in each of two planes 90° apart. The tapper shall be adjusted so that the peak acceleration level delivered to the tube is 75 G's as measured with a Gulton A-305 accelerometer and KA-1 kit. The shorts detecting equipment shall be a dc device capable of detecting as shorts the following interelement resistances of the given time durations.

Interelement Resistance	Time Duration
4.5 megohms or less	80 μsec or greater
2.2 megohms or less	27 μsec or greater
1.0 megohm or less	14 μsec or greater
0.1 megohm or less 10,000 ohms or less	4.5 μsec or greater
10,000 ohms or less	2.5 μsec or greater

Continuity testing shall be performed with tapping of the tube as specified in MIL-E-1 Par. 4.7.5.

Tubes which give indication of one or more of the following shall be rejected without retesting.

- (a) Any short during tapping
- (b) Any open circuit
- (c) Air leaks (as defined in MIL-E-1 Par. 3.2.4.3)
- 3: The tube shall be rigidly mounted on a table vibrating such that the instantaneous values of acceleration shall constitute approximately a "White Noise" spectrum which is free from discontinuities from 100 cps to 5000 cps. The spectrum of instantaneous acceleration shall be such that each octave of bandwidth delivers 2.3 G's rms acceleration. With this the case, the rms value of acceleration for any bandwidth within the specified spectrum is equal to

G rms = 2.3 G
$$\sqrt{3.32 \log_{10} (f2/f1)}$$

f2 and f1 are the upper and lower frequencies respectively of the band under consideration. The degree of clipping of the peak accelerations shall be such that the peak value of acceleration is at least 15 G's.

The voltage (ep) produced across the resistor (Rp) as a result of vibration shall be coupled through a compensating amplifier to a low pass filter. The compensating amplifier shall have a high input impedance of (0.25 megohm or more) and shall be adjusted to compensate for any insertion losses in the filter. The combined frequency response of amplifier and filter shall be flat within ± 0.5 db from 50 cps to 8000 cps, shall be down no more than 5 db at 10,000 cps and at 20 cps, and down at least 40 db at 13,000 cps. For reading the peak to peak value of output voltage the filter output shall be fed directly to the input of a Ballantine Model 305 peak to peak electronic voltmeter or equal, while the rms value shall be measured with a Hewlett-Packard Model 400C or equal.

- 4: Tubes subjected to the following destructive tests are not to be accepted under this specification.
 - 4.9.5.3 Subminiature lead fatigue
 - 4.9.20.5 Shock
 - 4.9.20.6 Fatigue
 - 4.11.7 Heater cycling life test
 - 4.11.5 Intermittent life test
- 5: Envelope temperature is defined as the highest temperature indicated when using a thermocouple of \$40 BS or smaller diameter elements welded to a ring of 0.025 inch diameter phosphor bronze placed in contact with the bulb. Envelope temperature requirement will be satisfied if a tube, having bogey Ib (±5%) under normal test conditions, is determined to operate at maximum specified temperature at any position on the life test rack.
- 6: The tubes shall be rigidly mounted on a table vibrating at a constant acceleration level of 10 G. The frequency of vibration shall be varied from 30 cps to 3000 cps and back to 30 cps with three minutes being the time required to sweep the range in each direction. The rate of change of frequency with time shall be such that the frequency various logarithmically with time. The tubes shall be vibrated for a total of six hours, that is two hours in each of the three positions X1, X2 and Y1. All general test voltages shall be applied to the tube under test.

ACCEPTANCE CRITERIA NOTES (Continued)

7: Prior to this test, tubes shall be preheated five (5) minutes at conditions indicated below. Test within three (3) seconds after preheating. Three-minute test is not permitted. Grid Emission shall be the last test performed on the sample selected for the Grid Emission Test.

Ef	Eb	Ec1	Ec2	$\mathbf{R}\mathbf{k}$	Rg1
V	Vdc	Vdc	Vdc	Ohms	Meg
7.5	250	0	150	680	4.0

- 8: Maximum total distortion of the filament supply voltage shall be 5%. The frequency response of the peak to peak measuring device from 20 cps to 5000 cps must be within 0.5 db of its response at 400 cps.
- 9: Insert a cold tube into the test socket having all Plate Current (1) conditions applied and record Ib continuously for three (3) minutes. Plate Current must reach 90% of the three (3) minute figure within the time indicated.

APPLICATION DATA

The Type 6788 is a Premium Subminiature sharp cutoff pentode designed for audio amplifier service. It has particular advantage as a high gain audio amplifier or regulator amplifier where high plate loads are desired at low plate current.

This type is characterized by extra-ordinary freedom from interelement short circuits of short term duration, by high resistance to interelement leakage, and by stable performance. In addition, vibrational output when the tube is subjected to wide band (White Noise) vibration is held to a very low value. It is designed for service at high altitudes and where severe conditions of mechanical shock, vibration and high temperature are encountered. These characteristics give the type special value in guided missile applications.

To insure correlation with actual field conditions and thereby enhance equipment reliability, vibrational noise output is controlled by the "white noise test" as shown in the acceptance criteria. Briefly, this test consists of subjecting the tube to a white noise vibration spectrum covering the frequency band of 100 to 5000 cps at a rms level of 2.3 g's per octave and a peak level of 15 g's.

Limits are shown for both peak and rms output. A further discussion of the white noise vibrational test is included in the frontal section of this manual.

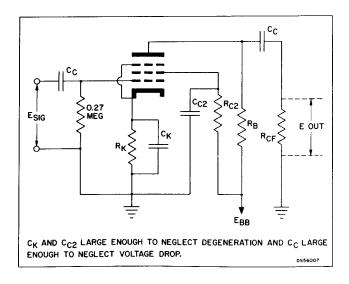
The 6788 is manufactured and inspected to meet the applicable specification for reliability. Life expectancy is described by the life tests, specified on the attached pages. The actual life expectancy of the tubes in an operating circuit is affected by both the operating and environmental conditions involved. Likewise, the life tests specified indicate performance under certain operating criteria to a set of specified end points. Performance at conditions other than those specified can usually be estimated only roughly as giving better or poorer life expectancy. For further discussion of life expectancy, reference should be made to the frontal section of this manual.

When operated under conditions common to on-off control applications, the tube exhibits freedom from the development of interface resistance. The heater-cathode construction is designed to withstand intermittent operation.

RESISTANCE COUPLED AMPLIFIER DATA

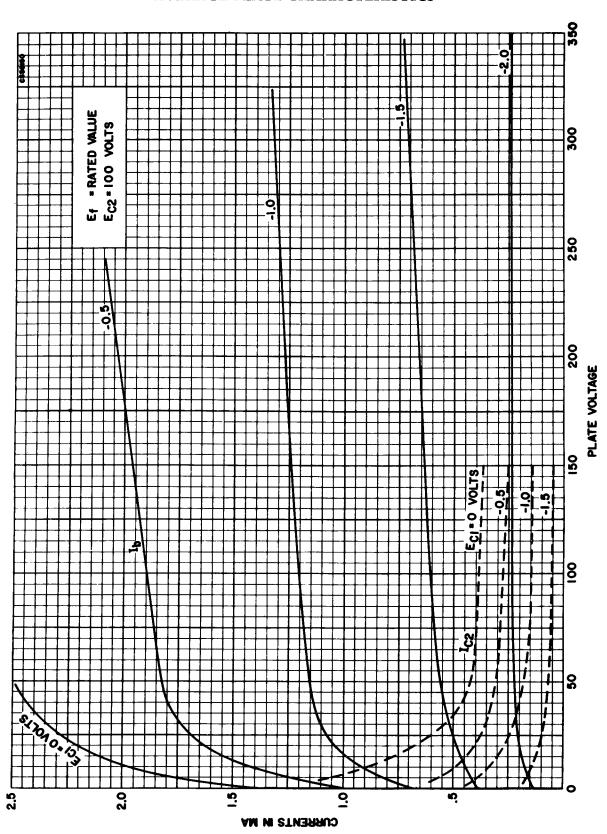
	Ebb = 100 Volts Ebb = 250 Volts											
Rb (megohms)).1 82).27 2.2		.47 3.9).1).82		.27 !.2		.47 3.9
Rcf (megohms). Rk (ohms). Ib (ma). Ic2 (ma). Ec1 (volts). Ec2 (volts). Eb (volts).	1800 .400 .055 82 54.1	0.47 1800 .400 .054 82 55.0 59.2	0.47 4700 .177 .024 95 46.2 51.2	1.0 3900 .187 .026 83 46.4 49.1	0.47 6800 .118 .016 91 38.7 44.6	1.0 6800 .116 .016 89 38.7 44.6	0.27 560 1.36 .19 87. 96. 113.	0.47 1000 1.16 .17 -1.36 113 129	0.47 1500 .575 .082 -1.02 72. 87.	1.0 1200 .61 .083 83 66. 85.	0.47 2200 .365 .050 92 56 76	1.0 2200 .367 .050 92 56 76
Esig (volts, rms)	0.05 3.3 66. 2.0	0.05 3.65 73. 2.0	0.05 4.5 90. 3.9	0.05 5.9 118. 3.75	0.05 4.7 94. 4.6	0.05 6.2 124. 4.25	0.10 9.3 93. 0.9	0.10 10.1 101. 1.0	0.10 16.2 162. 1.8	0.10 19.8 198. 1.15	0.10 18.2 182. 3.7	0.10 23.6 236. 3.2
Esig* (volts, rms)	5.9 65.5	0.10 7.28 72.8 3.8	0.07 6.3 90. 5.0	0.07 8.2 117. 5.0	0.06 5.6 93. 5.0	0.06 7.35 122. 5.0	0.18 16.6 92. 1.4	0.47 45. 96. 5.0	0.25 39. 156. 4.8	0.13 25.7 198. 1.70	0.14 25.3 181. 5.0	0.17 38. 224. 5.0

^{*}Maximum signal for 5% distortion or $\frac{1}{8}$ microampere grid current.

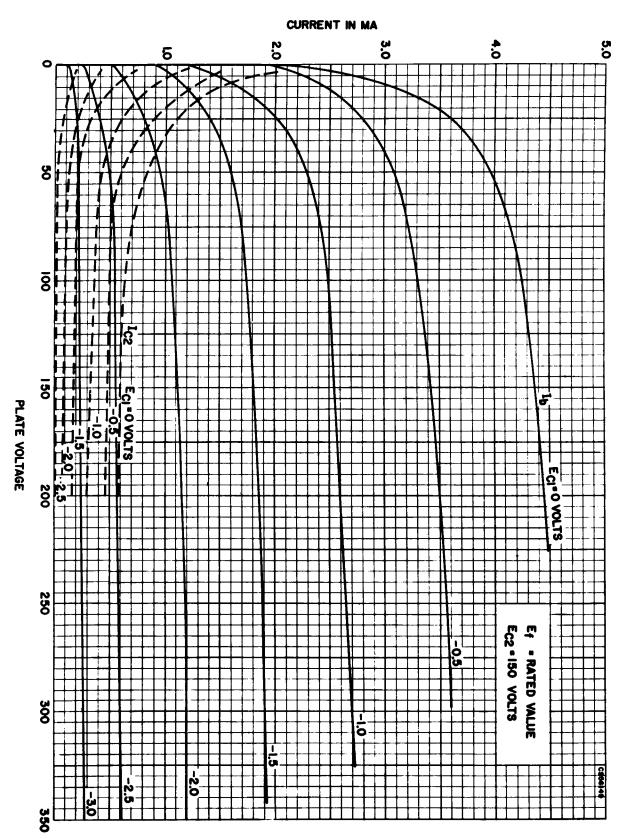


Resistance coupled amplifier circuit

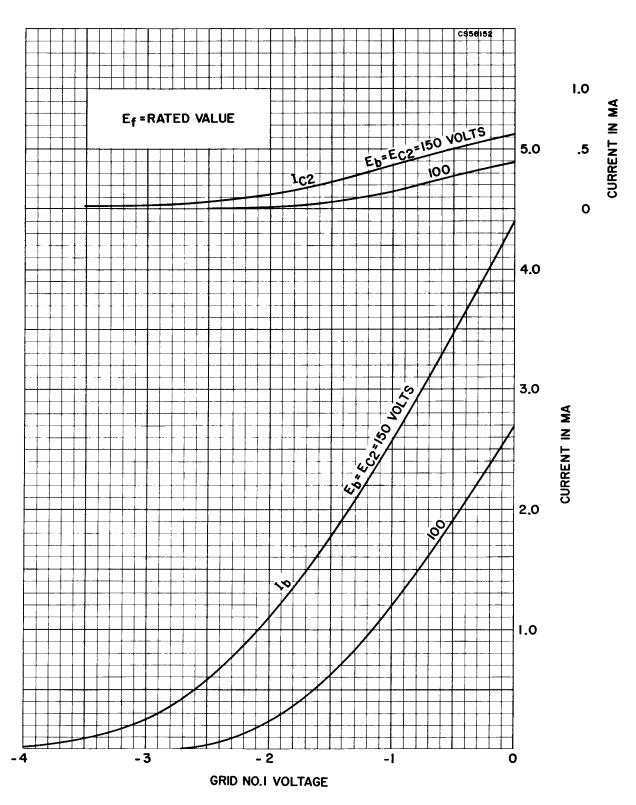
AVERAGE PLATE CHARACTERISTICS



AVERAGE PLATE CHARACTERISTICS



AVERAGE TRANSFER CHARACTERISTICS (PENTODE CONNECTED)



AVERAGE TRANSFER CHARACTERISTICS (PENTODE CONNECTED)

